


<b>Search Notes</b>  	<b>Application/Control No.</b>  10524366	<b>Applicant(s)/Patent Under Reexamination</b>  MEYER ET AL.
	<b>Examiner</b>  Hailey, Patricia L	<b>Art Unit</b>  1755

SEARCHED			
Class	Subclass	Date	Examiner
106	481, 482, 485, 487, 490, 491	4/7/09	PLH
423	335	4/7/09	PLH

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search; EAST search	4/7/09	PLH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
106	481, 482, 485, 487, 490, 491	4/7/09	PLH
423	335	4/7/09	PLH

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